



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

RF Exposure Evaluation

FCC ID: 2A6QM-WSS05-1A1

Measuring Standard

FCC Part 1(1.1310) and Part 2(2.1091)

KDB 680106 D01 RF Exposure Wireless Charging Base App v03

Test Configuration

The test distance is from the center of the probe to the edge of the EUT.

The test distance of Position A,B,C,D,E is from 0 cm to 20 cm,in 2 cm

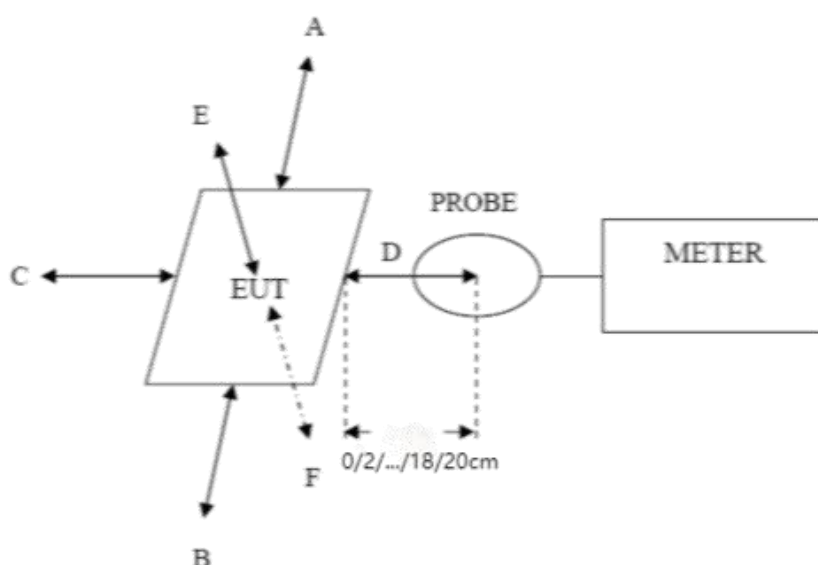
increment measured from the edge of the device.Using the equipment list below for determining compliance with the MPE requirements of FCC Part 1.1310.

The RF power density was measured at Under maximum load test.

This device uses a wireless charging circuit for power transfer operating at the frequency of 115KHz -205kHz.

Thus, the 300kHz limits were used: E-field Limit = 614 (V/m); H-field limit = 1.63 (A/m).

TEST Setup





Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai
Street, Bao' an District, Shenzhen, China

TEST Limits

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposure				
0.3-3.0	614	1.63	*100	6
3.0-30	1842/f	4.89/f	*900/f ²	6
30-300	61.4	0.163	1.0	6
300-1,500			f/300	6
1,500-100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*100	30
1.34-30	824/f	2.19/f	*180/f ²	30
30-300	27.5	0.073	0.2	30
300-1,500			f/1500	30
1,500-100,000			1.0	30

f = frequency in MHz * = Plane-wave equivalent power density

Measurement Uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the KSIGN Testing Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Below is the best measurement capability for KSIGN Testing Co., Ltd.

Test Items	Measurement Uncertainty	Notes
All emissions,radiated(<30M)(9kHz-30MHz)	2.20 dB	(1)

Note(1): This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai
Street, Bao' an District, Shenzhen, China

Measuring Device and Test Equipment

Description	Manufacturer	Model	S/N	Cal. Until
Probe FHP(1Hz-400kHz)	Narda Safety Test Solutions GmbH	EHP-50F	J-0015	June 10, 2022
PHONE 1	HUAWEI	P40	N/A	N/A

TEST MODE

MODE	TEST MODE DESCRIPTION
1	Wireless charging mode(Full load)
2	Wireless charging mode(Half load)
3	Wireless charging mode(Null load)



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai
Street, Bao' an District, Shenzhen, China

TEST RESULT

☒ Passed

☐ Not Applicable

EUT	Wireless Power Bank	Model Name. :	WSS05-1A1
Pressure:	1010hPa	Test Date:	2022-03-22
Test Voltage:	Output: 15W(Max)		

H-Field Strength at 0cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.58	0.73	0.75	0.94	0.70	0.88	0.62	0.78	0.75	0.94	1.63
Half load	115~205	0.53	0.66	0.64	0.80	0.65	0.81	0.59	0.74	0.72	0.90	
Null load	115~205	0.53	0.66	0.63	0.79	0.62	0.78	0.58	0.73	0.72	0.90	

H-Field Strength at 2cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.51	0.64	0.68	0.85	0.63	0.79	0.55	0.69	0.68	0.85	1.63
Half load	115~205	0.48	0.60	0.59	0.74	0.60	0.75	0.54	0.68	0.67	0.84	
Null load	115~205	0.48	0.60	0.58	0.73	0.57	0.71	0.53	0.66	0.67	0.84	



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

H-Field Strength at 4cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.46	0.58	0.63	0.79	0.58	0.73	0.50	0.63	0.63	0.79	1.63
Half load	115~205	0.43	0.54	0.54	0.68	0.55	0.69	0.49	0.61	0.62	0.78	
Null load	115~205	0.40	0.50	0.50	0.63	0.49	0.61	0.45	0.56	0.59	0.74	

H-Field Strength at 6cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.42	0.53	0.59	0.74	0.54	0.68	0.46	0.58	0.59	0.74	1.63
Half load	115~205	0.36	0.45	0.47	0.59	0.48	0.60	0.42	0.53	0.55	0.69	
Null load	115~205	0.35	0.44	0.45	0.56	0.44	0.55	0.40	0.50	0.54	0.68	

H-Field Strength at 8cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.37	0.46	0.54	0.68	0.49	0.61	0.41	0.51	0.54	0.68	1.63
Half load	115~205	0.31	0.39	0.42	0.53	0.43	0.54	0.37	0.46	0.50	0.63	
Null load	115~205	0.28	0.35	0.38	0.48	0.37	0.46	0.33	0.41	0.47	0.59	



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

H-Field Strength at 10cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.31	0.39	0.48	0.60	0.43	0.54	0.35	0.44	0.48	0.60	1.63
Half load	115~205	0.26	0.33	0.37	0.46	0.38	0.48	0.32	0.40	0.45	0.56	
Null load	115~205	0.22	0.28	0.32	0.40	0.31	0.39	0.27	0.34	0.41	0.51	

H-Field Strength at 12cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.24	0.30	0.41	0.51	0.36	0.45	0.28	0.35	0.41	0.51	1.63
Half load	115~205	0.18	0.23	0.29	0.36	0.30	0.38	0.24	0.30	0.37	0.46	
Null load	115~205	0.18	0.23	0.28	0.35	0.27	0.34	0.23	0.29	0.37	0.46	

H-Field Strength at 14cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.21	0.26	0.38	0.48	0.33	0.41	0.25	0.31	0.38	0.48	1.63
Half load	115~205	0.15	0.19	0.26	0.33	0.27	0.34	0.21	0.26	0.34	0.43	
Null load	115~205	0.14	0.18	0.24	0.30	0.23	0.29	0.19	0.24	0.33	0.41	



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

H-Field Strength at 16cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.18	0.23	0.35	0.44	0.30	0.38	0.22	0.28	0.35	0.44	1.63
Half load	115~205	0.12	0.15	0.23	0.29	0.24	0.30	0.18	0.23	0.31	0.39	
Null load	115~205	0.11	0.14	0.21	0.26	0.20	0.25	0.16	0.20	0.30	0.38	

H-Field Strength at 18cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.15	0.19	0.32	0.40	0.27	0.34	0.19	0.24	0.32	0.40	1.63
Half load	115~205	0.09	0.11	0.20	0.25	0.21	0.26	0.15	0.19	0.28	0.35	
Null load	115~205	0.07	0.09	0.17	0.21	0.16	0.20	0.12	0.15	0.26	0.33	

H-Field Strength at 20cm surrounding the EUT												
EUT Side	Frequency Range (kHz)	Probe A		Probe B		Probe C		Probe D		Probe E		Limits (A/m)
		A/m	uT	A/m	uT	A/m	uT	A/m	uT	A/m	uT	
Full load	115~205	0.11	0.14	0.28	0.35	0.23	0.29	0.15	0.19	0.28	0.35	1.63
Half load	115~205	0.05	0.06	0.16	0.20	0.17	0.21	0.11	0.14	0.24	0.30	
Null load	115~205	0.05	0.06	0.15	0.19	0.14	0.18	0.10	0.13	0.24	0.30	

Note: Calculation: $A/m = uT/1.25$

Remark: The device meets the mobile RF exposure limit at a 15cm separation distance as specified in §2.1091 of the FCC Rules

Note: H-Field Strength less than 50% of the applicable MPE limit.



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

PHOTOGRAPHS OF TEST SETUP

Position E

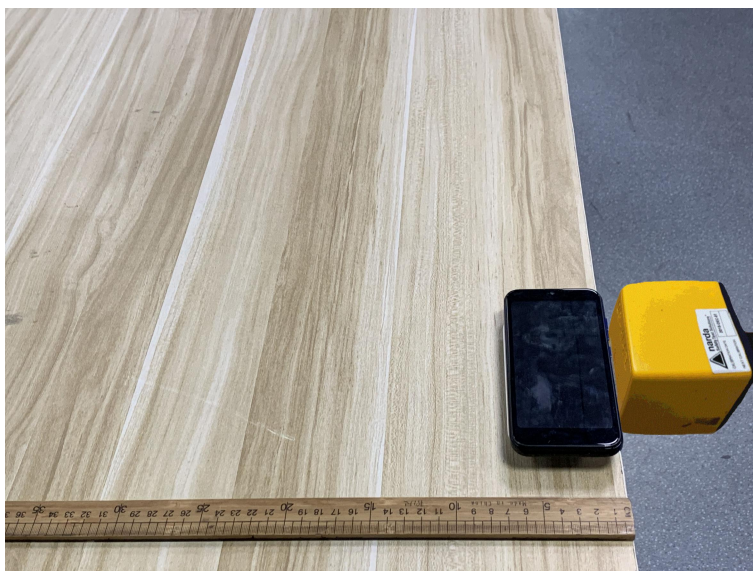
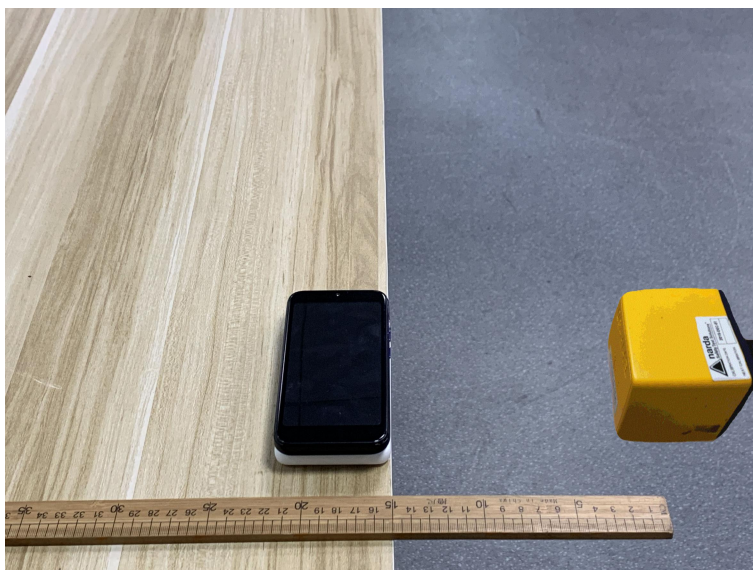




Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai
Street, Bao' an District, Shenzhen, China

Position A

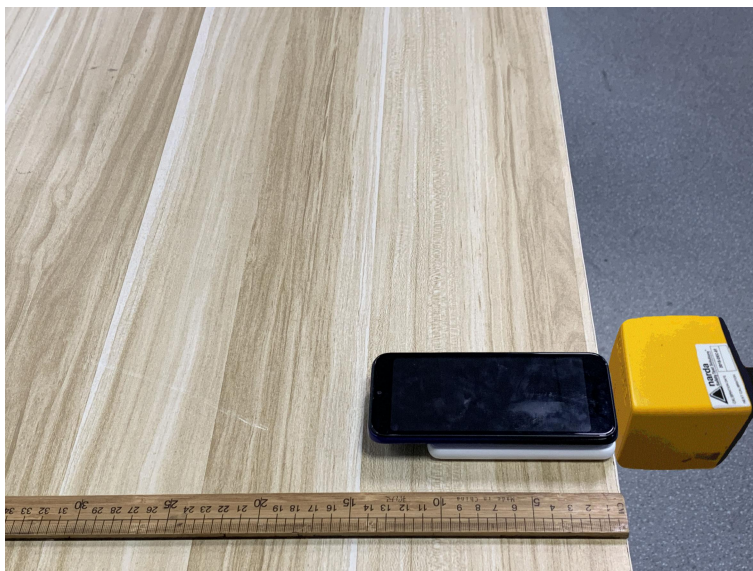
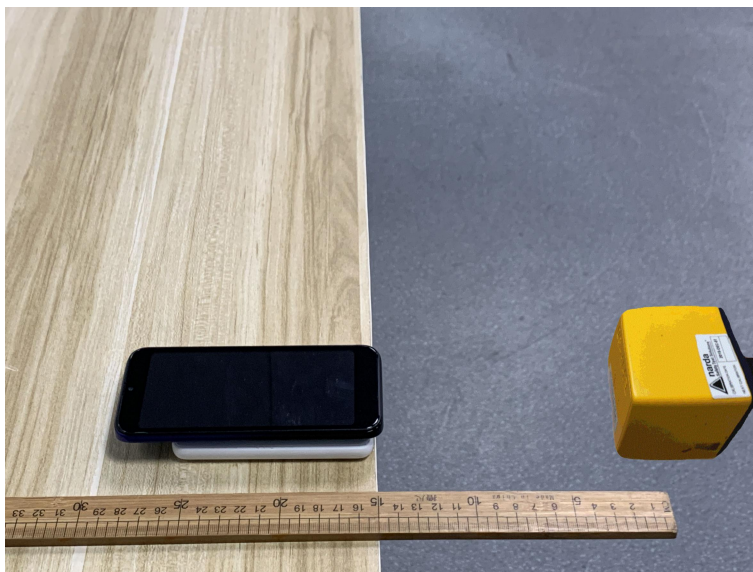




Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

Position B

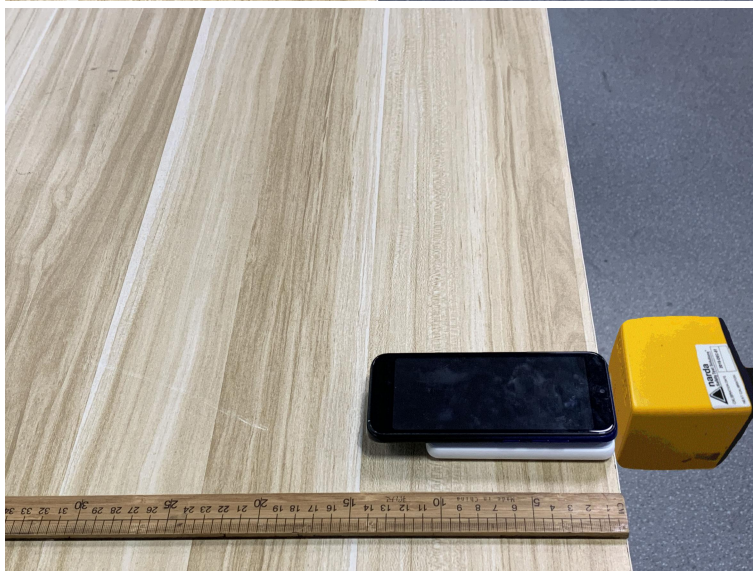




Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

Position C

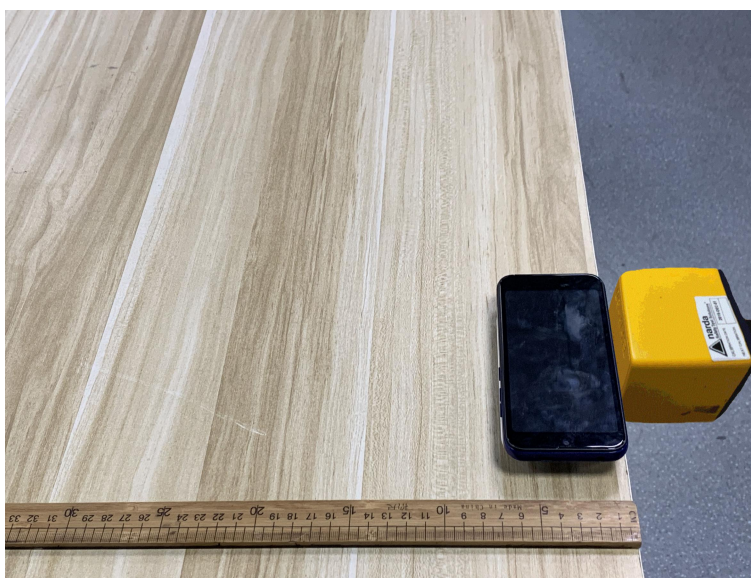
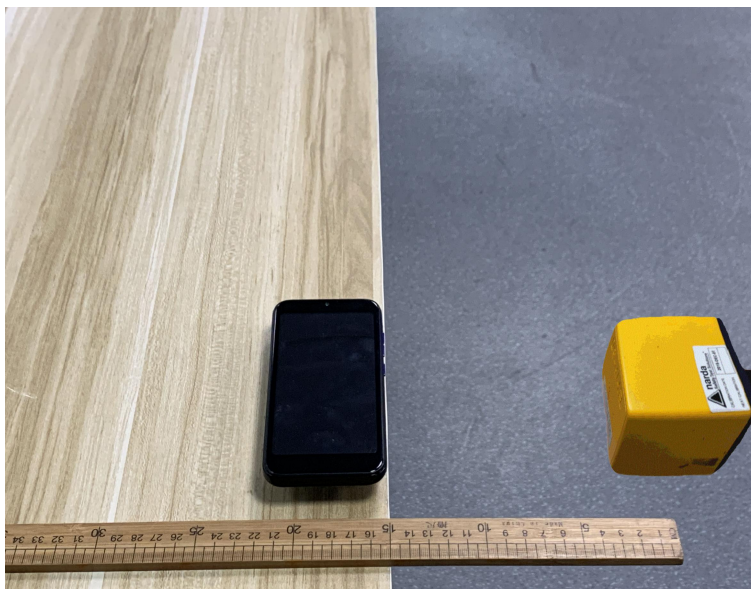




Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao' an District, Shenzhen, China

Position D



***** End of Report *****